Subst. Form PTO-1449	Atty. Docket No.: RPS9200101720S1	(IRA-10-5709)	Serial No.: To be assigned
APPLICANTS INFORMATION DISCLOSURE STATEMENT			
	Applicant: Atoji et al		
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[•] EXAMINER: Initial if reference considered, whether or not citation is in conformation with MPEP 609; draw line through citation if in conformance and not considered. Include copy of this form with next communication to applicant.